High performance X-Ray spectroscopy

With Programmable Systems on Chip

Electromagnetic Radiation Spectrum

Speed of light in vacuum $C \approx 3x10^8 \text{ m/s}$

$$C = \lambda f$$

Quantization of energy,

wave-particle duality,

Planck's Law:

E = h f

where $h = 4.135 \times 10^{-15} \text{ eV seconds}$

Frequency (Hz)	Wavelength (m)	Energy (eV)
3.00E+22	1.00E-14	1.24E+09
3.00E+21	1.00E-13	1.24E+08
3.00E+20	1.00E-12	1.24E+07
3.00E+19	1.00E-11	1.24E+06
3.00E+18	1.00E-10	1.24E+05
3.00E+17	1.00E-09	1.24E+04
3.00E+16	1.00E-08	1.24E+03
3.00E+15	1.00E-07	1.24E+02
3.00E+14	1.00E-06	1.24E+01
3.00E+13	1.00E-05	1.24E+00
3.00E+12	1.00E-04	1.24E-01
3.00E+11	1.00E-03	1.24E-02
3.00E+10	1.00E-02	1.24E-03
3.00E+09	1.00E-01	1.24E-04
3.00E+08	1.00E+00	1.24E-05
3.00E+07	1.00E+01	1.24E-06
3.00E+06	1.00E+02	1.24E-07
3.00E+05	1.00E+03	1.24E-08
3.00E+04	1.00E+04	1.24E-09
3.00E+03	1.00E+05	1.24E-10

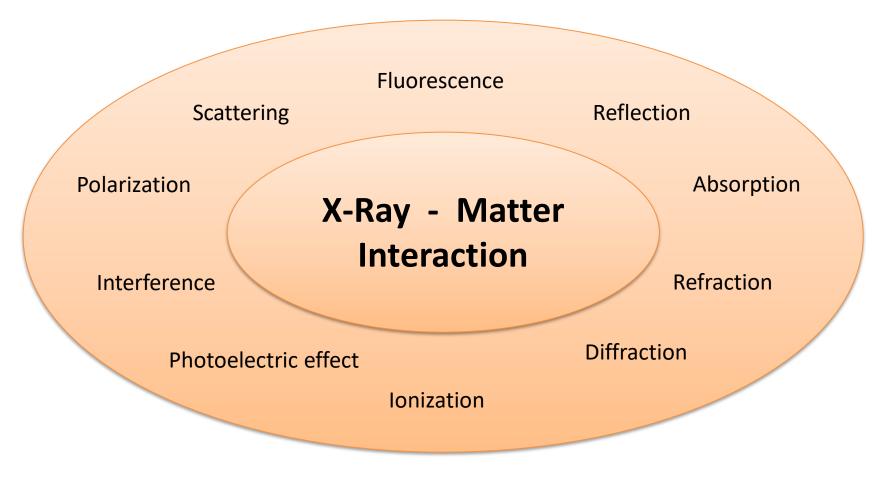
Cosmic Rays Gamma

X-Rays

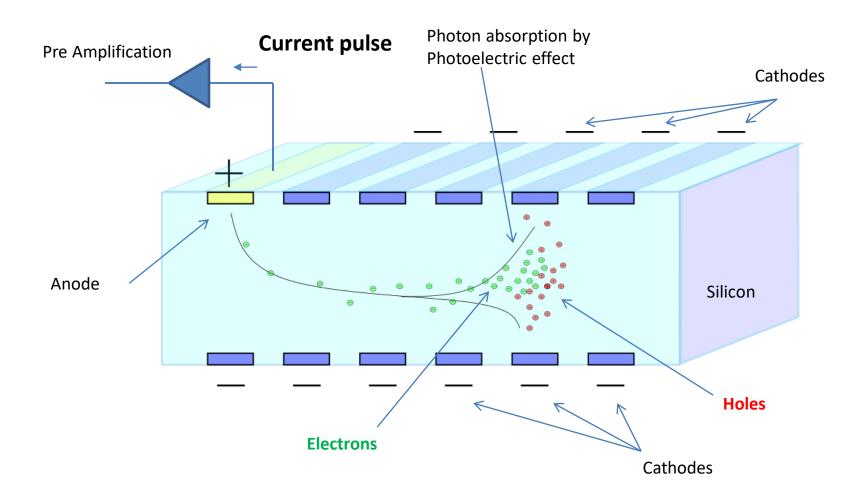
Ultraviolet Visible Infrared

Radar GPS Microwaves TV FM Radio Waves

X-Ray Photons



X-Ray Photons Detection

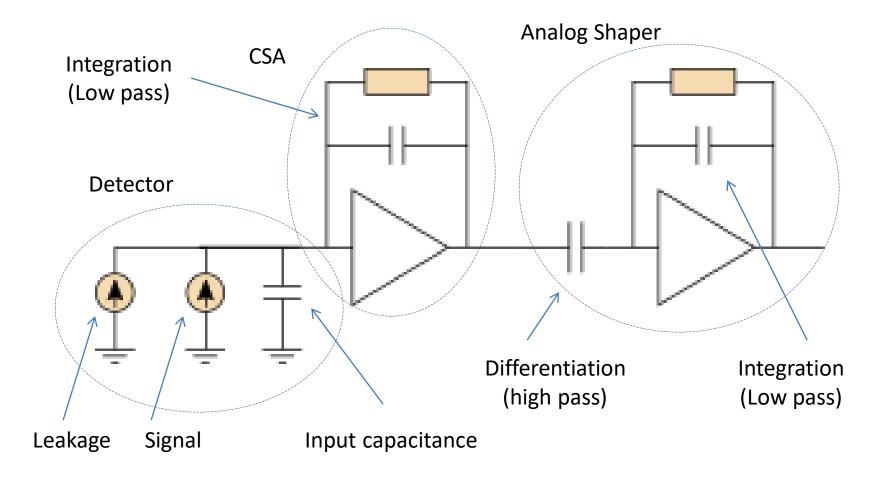


Digital Pulse Processing

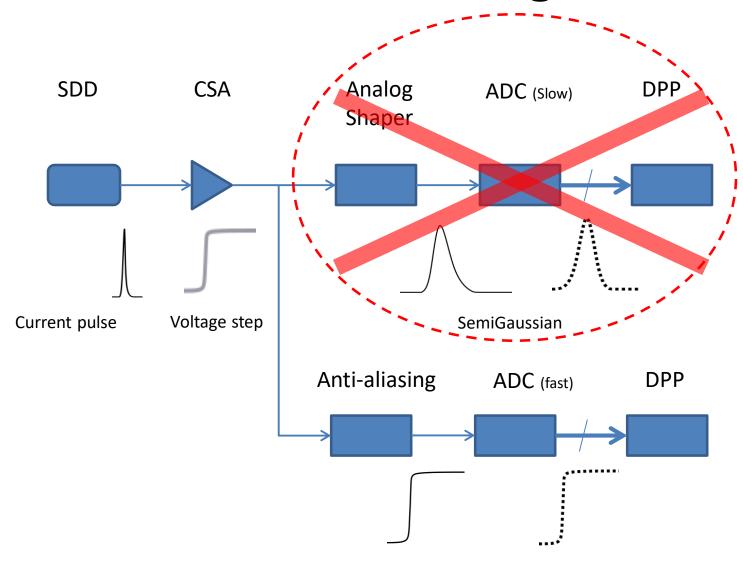
Desirable features in modern X-Ray spectroscopy

- Single photon detection capability
- High energy resolution
- Extended energy range
- High photon counting rates
- Effective and efficient pile-up rejection capability
- High time resolution and time-stamping capability
- Adaptability to different requirements and experimental conditions such as
 - Flexible tradeoffs between energy resolution and detection efficiency
 - Possible optimization to different noise conditions and signal shapes

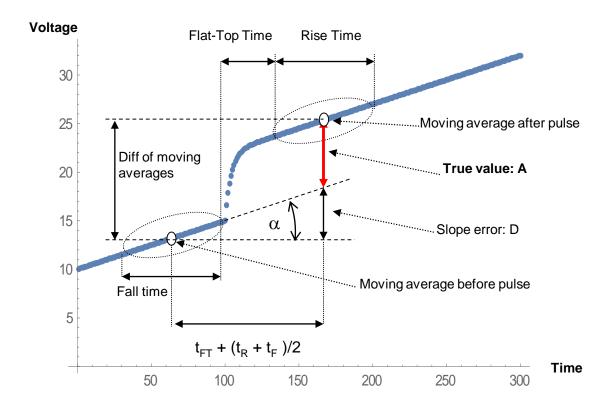
Detector, CSA, Pulse Shaper



Pulse Processing Chain

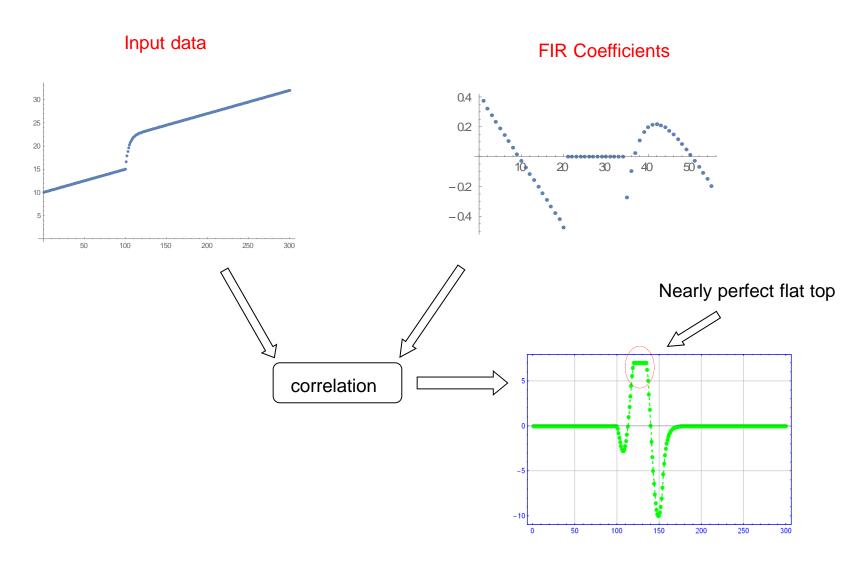


Time Domain Analysis of a Typical Voltage Step

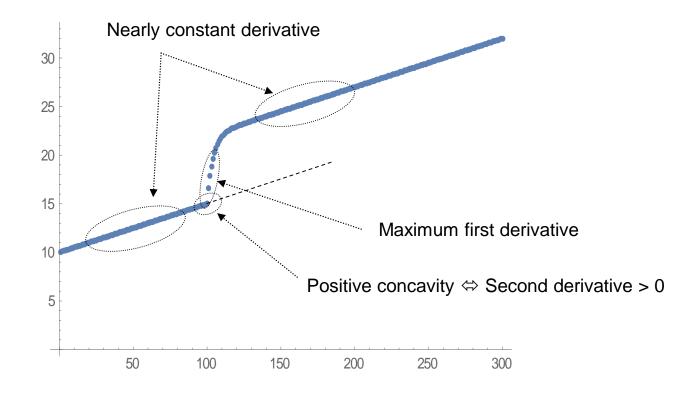


The true value can be calculated by mean of additions and multiplications

Digital Pulse Processing I: Measuring Amplitudes

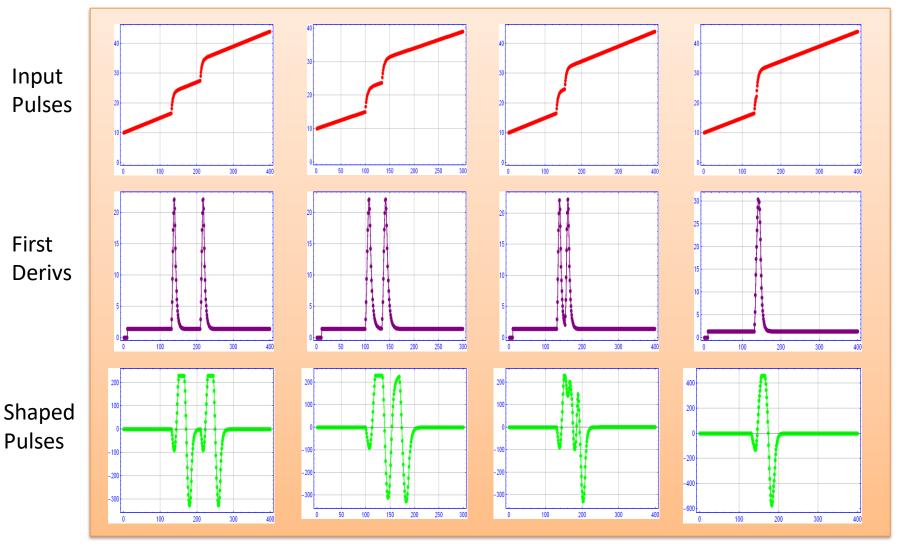


Digital Pulse Processing II: Detecting Arrival Times

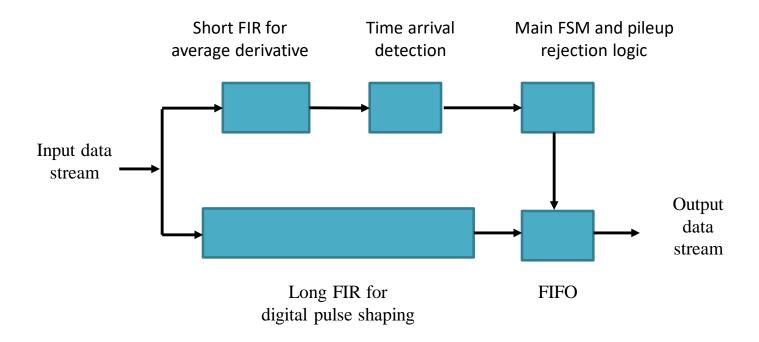


A short FIR can compute different discrete derivatives

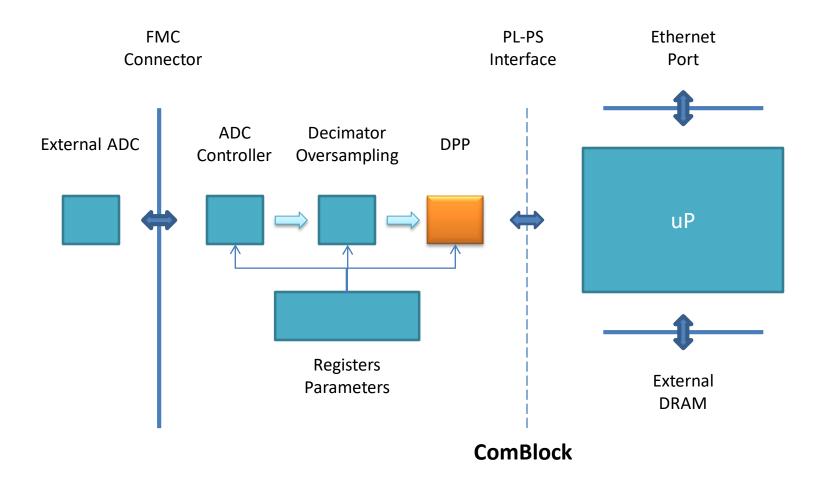
Digital Pulse Processing III: Pile-up Rejection



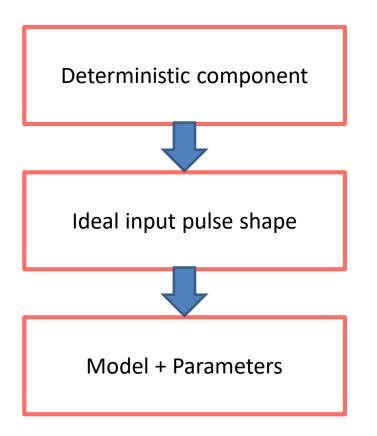
Digital Pulse Processor

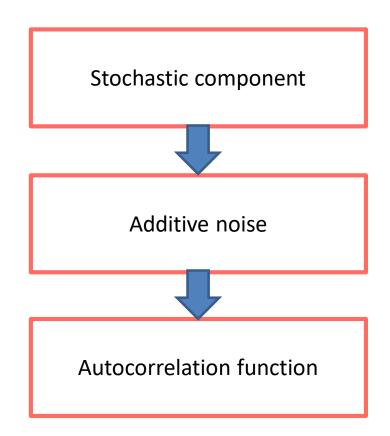


DPP Context in SOC: Global Architecture



Input signal analysis





Input pulse modeling I

The ideal case corresponding to a single photon detection is represented by the step function S_i

$$S_i = \begin{cases} 0, & i \le t_0 \\ A, & i > t_0 \end{cases}$$

finite frequency response of the CSA determines a limited rise time that could be modeled (1st aprox) as an exponential growth

$$S_i = \begin{cases} 0, & i \le t_0 \\ A(1 - e^{-(i - t_0)/\tau}), & i > t_0 \end{cases}$$

A constant detector leakage current determines a baseline with a steady slope and a variable offset on top of which the signal segment must be processed

$$S_{i} = \begin{cases} B_{0} + iB_{1}, & i \leq t_{0} \\ A\left(1 - e^{-(i - t_{0})/\tau}\right) + B_{0} + iB_{1}, & i > t_{0} \end{cases}$$

Several sources of noise will contribute with an additive spurious signal n_i that degrades the voltage step measurement

$$S_{i} = \begin{cases} B_{0} + iB_{1}, & i \leq t_{0} \\ A\left(1 - e^{-(i-t_{0})/\tau}\right) + B_{0} + iB_{1}, & i > t_{0} \end{cases}$$

$$S_{i} = \begin{cases} B_{0} + iB_{1} + n_{i}, & i \leq t_{0} \\ A\left(1 - e^{-(i-t_{0})/\tau}\right) + B_{0} + iB_{1} + n_{i}, & i > t_{0} \end{cases}$$

Input pulse modeling II

Pile up: Being a Poissonian process, two or more photons could be absorbed in the SDD within any arbitrary small time window. The superposition of two photons absorbed at times t_0 and t_1 and respectively with amplitudes A_0 and A_1 is then given by

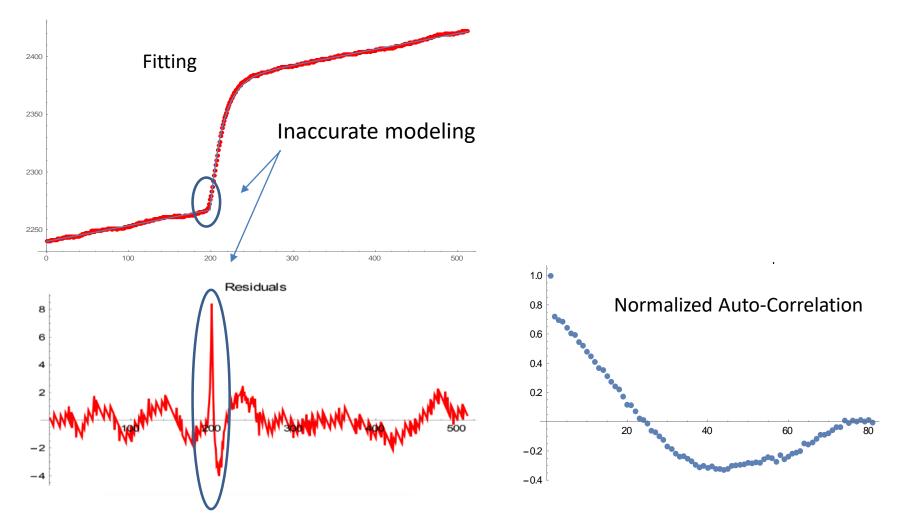
$$S_{i} = \begin{cases} B_{0} + iB_{1} + n_{i}, & i \leq t_{0} \\ A_{0} \left(1 - e^{-(i-t_{0})/\tau} \right) + B_{0} + iB_{1} + n_{i}, & t_{0} < i \leq t_{1} \\ A_{0} \left(1 - e^{-(i-t_{0})/\tau} \right) + A_{1} \left(1 - e^{-(i-t_{1})/\tau} \right) + B_{0} + iB_{1} + n_{i}, & i > t_{1} \end{cases}$$

Input pulse modeling III

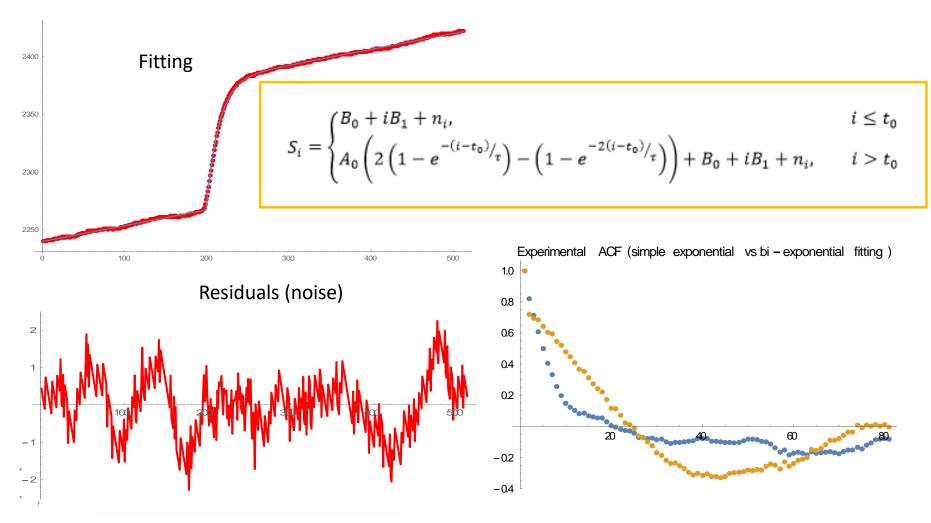
. . . and in general for m+1 photons

$$S_{i} = \begin{cases} B_{0} + iB_{1} + n_{i}, & i \leq t_{0} \\ A_{0} (1 - e^{-(i-t_{0})/\tau}) + B_{0} + iB_{1} + n_{i}, & t_{0} < i \leq t_{1} \\ A_{0} (1 - e^{-(i-t_{0})/\tau}) + A_{1} (1 - e^{-(i-t_{1})/\tau}) + B_{0} + iB_{1} + n_{i}, & t_{1} < i \leq t_{2} \\ \vdots & \vdots & \vdots \\ \sum_{j=0}^{m} A_{j} (1 - e^{-(i-t_{j})/\tau}) + B_{0} + iB_{1} + n_{i}, & i > t_{m} \end{cases}$$

Input noise characterization



Input noise characterization



Summary of main characteristics of a configurable/programmable DPP

- Energy measurement range
- Energy resolution
- Time resolution
- Photon counting
- Dead time measurement
- Pile-up rejection
- Max measurement photon rate
- Max counting photon rate
- Area, performance, power consumption
- Pulse shapes discrimination

More details in

Data Analysis and Filter Optimization for Pulse-Amplitude Measurement: A Case Study on High-Resolution X-ray Spectroscopy

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by ② Kasun Sameera Mannatunga 1,2,3 ☑ <sup>10</sup>, ② Bruno Valinoti 1,4,5,* ☑ <sup>10</sup>, ② Werner Florian Samayoa 1,5 ☑ <sup>10</sup>, ② Maria Liz Crespo 1,* ☑ <sup>10</sup>, ② Andres Cicuttin 1 ☑ <sup>10</sup>, ② Jerome Folla Kamdem 1,6 ☑ <sup>10</sup>, ② Luis Guillermo Garcia 1,5 ☑ <sup>10</sup> and ② Sergio Carrato 5 ☑ <sup>10</sup> Sensors 2022, 22(13), 4776; https://doi.org/10.3390/s22134776
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A programmable System-on-Chip based digital pulse processing for high resolution X-ray spectroscopy, A. Cicuttin et al., 2016 International Conference on Advances in Electrical, Electronic and Systems Engineering (ICAEES), 2016, pp. 520-525, doi: 10.1109/ICAEES.2016.7888100.